

Application/Control No.	lo. Applicant(s)/Patent under Reexamination	
10/603,623	KATATA, KEIJI	
Examiner	Art Unit	
Daniel Tekle	2621	

	SEARCHED				
Class	Subclass	Date	Examiner		
386	95	4/2/2007	DT		
386	125-126	4/2/2007	DT		
369	47.14	4/2/2007	ÞΤ		
369	53.17	4/2/2007	DT		
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Subclass	Data	
	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) and search query attached	4/2/2007	DT
combined citation and NPL	4/2/2007	DT
Inventor search	4/2/2007	DT
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